## IGBT with Diode ISOPLUS 247 ${ }^{\text {TM }}$

(Electrically Isolated Backside)

## Short Circuit SOA Capability

Preliminary Data Sheet

| Symbol | Test Conditions | Maximum Ratings |  |
| :---: | :---: | :---: | :---: |
| $\mathrm{V}_{\text {ces }}$ | $\mathrm{T}_{J}=25^{\circ} \mathrm{C}$ to $150^{\circ} \mathrm{C}$ | 600 | V |
| $V_{\text {cGR }}$ | $\mathrm{T}_{\mathrm{J}}=25^{\circ} \mathrm{C}$ to $150^{\circ} \mathrm{C} ; \mathrm{R}_{\mathrm{GE}}=1 \mathrm{M} \Omega$ | 600 | V |
| $V_{\text {GES }}$ | Continuous | $\pm 20$ | V |
| $\mathrm{V}_{\text {GEM }}$ | Transient | $\pm 30$ | V |
| $\mathrm{I}_{\mathrm{C} 25}$ | $\mathrm{T}_{\mathrm{C}}=25^{\circ} \mathrm{C}$ | 70 | A |
| $\mathrm{I}_{\text {c90 }}$ | $\mathrm{T}_{\mathrm{C}}=90^{\circ} \mathrm{C}$ | 45 | A |
| $\mathrm{I}_{\mathrm{CM}}$ | $\mathrm{T}_{\mathrm{C}}=25^{\circ} \mathrm{C}, 1 \mathrm{~ms}$ | 150 | A |
| $\begin{aligned} & \text { SSOA } \\ & \text { (RBSOA) } \end{aligned}$ | $\mathrm{V}_{\mathrm{GE}}=15 \mathrm{~V}, \mathrm{~T}_{\mathrm{VJ}}=125^{\circ} \mathrm{C}, \mathrm{R}_{\mathrm{G}}=22 \Omega$ <br> Clamped inductive load | $\begin{gathered} \mathrm{l}_{\text {CM }}=100 \\ @ 0.8 \mathrm{~V}_{\text {CES }} \end{gathered}$ | A |
| $\begin{aligned} & \mathbf{t}_{\mathrm{sc}} \\ & (\mathrm{SCSOA}) \end{aligned}$ | $\begin{aligned} & \mathrm{V}_{\mathrm{GE}}=15 \mathrm{~V}, \mathrm{~V}_{\mathrm{CE}}=360 \mathrm{~V}, \mathrm{~T}_{J}=125^{\circ} \mathrm{C} \\ & \mathrm{R}_{\mathrm{G}}=22 \Omega, \text { non repetitive } \end{aligned}$ | 10 | $\mu \mathrm{s}$ |


| $\mathrm{P}_{\mathrm{c}}$ | $\mathrm{T}_{\mathrm{C}}=25^{\circ} \mathrm{C}$ |  | 250 | W |
| :---: | :---: | :---: | :---: | :---: |
| $\mathrm{T}_{J}$ |  |  | $-55 \ldots+150$ | ${ }^{\circ} \mathrm{C}$ |
| $\mathrm{T}_{\text {JM }}$ |  |  | 150 | ${ }^{\circ} \mathrm{C}$ |
| $\mathrm{T}_{\text {stg }}$ |  |  | $-55 \ldots+150$ | ${ }^{\circ} \mathrm{C}$ |
| $\mathrm{V}_{\text {ISoL }}$ | $50 / 60 \mathrm{~Hz}$, RMS | $\mathrm{t}=1 \mathrm{~min}$ leads-to housing | 2500 | V |
| Maxim | ad temperature f | soldering | 300 | ${ }^{\circ} \mathrm{C}$ |

1.6 mm ( 0.062 in .) from case for 10 s

Weight
5

Symbol
Test Conditions
Characteristic Values ( $\mathrm{T}_{\mathrm{J}}=25^{\circ} \mathrm{C}$, unless otherwise specified) min. typ. $^{\text {ty }}$ max.



Maximum Ratings


ISOPLUS $247^{\text {TM }}$


$$
\mathrm{G}=\text { Gate }, \quad \mathrm{C}=\text { Collector },
$$

* Patent pending


## Features

- DCB Isolated mounting tab
- Meets TO-247AD package Outline
- High current handling capability
- Latest generation $\mathrm{HDMOS}^{\text {TM }}$ process
- MOS Gate turn-on
- drive simplicity


## Applications

- Uninterruptible power supplies (UPS)
- Switched-mode and resonant-mode power supplies
- AC motor speed control
- DC servo and robot drives
- DC choppers


## Advantages

- Easy assembly
- High power density
- Very fast switching speeds for high frequency applications

| Symbol | Test Conditions $\left(\mathrm{T}_{J}=25^{\circ} \mathrm{C},\right. \text { unless }$ | Characteristic Values ( $\mathrm{T}_{\mathrm{J}}=25^{\circ} \mathrm{C}$, unless otherwise specified) |  |
| :---: | :---: | :---: | :---: |
| $\mathrm{g}_{\text {Is }}$ | $\mathrm{I}_{\mathrm{C}}=\mathrm{I}_{\mathrm{T}} ; \mathrm{V}_{\text {CE }}=10 \mathrm{~V}, \quad 16$ | 23 | S |
| $\mathrm{I}_{\text {cON) }}$ | $\mathrm{V}_{\mathrm{GE}}=15 \mathrm{~V}, \mathrm{~V}_{\mathrm{CE}}=10 \mathrm{~V}$ | 210 | A |
| $\mathrm{C}_{\text {iss }}$ |  | 3850 | pF |
| $\mathrm{C}_{\text {oss }}$ | $\mathrm{V}_{\mathrm{GS}}=0 \mathrm{~V}, \mathrm{~V}_{\mathrm{DS}}=25 \mathrm{~V}, \mathrm{f}=1 \mathrm{MHz}$ | 440 | pF |
| $\mathrm{C}_{\text {rss }}$ |  | 50 | pF |
| Q |  | 167 | nC |
| $\mathrm{Q}_{\mathrm{ge}}$ | $\mathrm{I}_{\mathrm{C}}=\mathrm{I}_{\mathrm{T},} \mathrm{V}_{\mathrm{GE}}=15 \mathrm{~V}, \mathrm{~V}_{\text {CE }}=0.5 \mathrm{~V}_{\text {CES }}$ | 45 | nC |
| $\mathrm{Q}_{\mathrm{gc}}$ |  | 88 | nC |
| $\mathrm{t}_{\text {don }}$ | Inductive load, $\mathrm{T}_{\mathrm{J}}=25^{\circ} \mathrm{C}$ | 70 | ns |
| $\mathrm{t}_{\mathrm{ri}}$ | $\mathrm{I}_{\mathrm{C}}=\mathrm{I}_{\mathrm{T}, \mathrm{V}_{\mathrm{GE}}=15 \mathrm{~V}}$ | 70 | ns |
| $\mathrm{t}_{\text {doflo }}$ | $\mathrm{V}_{\text {CE }}=0.8 \mathrm{~V}_{\text {CES }}, \mathrm{R}_{\mathrm{G}}=2.7 \Omega$ | 150 | 300 ns |
| $\mathrm{t}_{\mathrm{if}}$ | Remarks: Switching times may increase | 150 | 300 ns |
| $\mathrm{E}_{\text {off }}$ | for $\mathrm{V}_{\text {CE }}$ (Clamp) $>0.8 \mathrm{~V}_{\text {CES }}$, higher $\mathrm{T}_{J}$ or increased $\mathrm{R}_{\mathrm{G}}$ | 3.3 | 6.0 mJ |
| $\mathrm{t}_{\text {d(on) }}$ | Inductive load, $\mathrm{T}_{\mathrm{J}}=125^{\circ} \mathrm{C}$ | 70 | ns |
| $\mathrm{t}_{\text {ri }}$ | $\mathrm{I}_{\mathrm{C}}=\mathrm{I}_{\mathrm{T},} \mathrm{V}_{\mathrm{GE}}=15 \mathrm{~V}$ | 70 | ns |
| $\mathrm{E}_{\text {on }}$ | $\mathrm{V}_{\text {CE }}=0.8 \mathrm{~V}_{\text {CES }}, \mathrm{R}_{\mathrm{G}}=2.7 \Omega$ | 2.5 | mJ |
| $\mathrm{t}_{\text {dolof) }}$ | Remarks: Switching times may increase | 230 | ns |
| $\mathrm{t}_{\text {fi }}$ | for $\mathrm{V}_{\text {CE }}$ (Clamp) $>0.8 \mathrm{~V}_{\text {CES }}$, higher $\mathrm{T}_{J}$ or increased $\mathrm{R}_{\mathrm{a}}$ | 230 | ns |
| $\mathrm{E}_{\text {off }}$ |  | 4.8 | mJ |
| $\mathrm{R}_{\text {tuc }}$ |  |  | $0.50 \mathrm{~K} / \mathrm{W}$ |
| $\mathrm{R}_{\text {thck }}$ |  | 0.15 | KW |

## Reverse Diode (FRED)

Symbol Test Conditions


Characteristic Values ( $\mathrm{T}_{\mathrm{J}}=25^{\circ} \mathrm{C}$, unless otherwise specified) min. ${ }^{\text {typ. }} \mid$ max. min.

Note: 1. $I_{T}=50 \mathrm{~A}$


See IXSK50N60BD1 data sheetfor characteristic curves.

